

**Search Notes**

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Examiner

Benjamin P. Geib

Applicant(s)/Patent under  
Reexamination

THEIS, JEAN-PAUL

Art Unit

2181

**SEARCHED**

Class	Subclass	Date	Examiner
712	225	10/2/2006	BPG

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search	10/2/2006	BPG
Google Scholar Search	10/2/2006	BPG